MT3205A

N-Channel Power MOSFET 60V, 140A, 3.6m Ω

General Description

This N-channel MOSFET is produced using MOS-TECH Semiconductor's advanced PowerTrench process that has been especially tailored to minimize the on-state resistance and yet maintain superior switching performance.

Features

- R $_{DS(on)}$ = 3.6m Ω (Typ.)@ V_{GS} = 10V, I_{D} = 100A
- High performance trench technology for extremely low RDS(ON)
- · High power and current handling capability
- · RoHS compliant

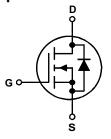
Applications

DC/DC converters

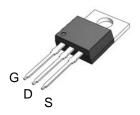


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Simplified Schematic



MARKING DIAGRAM & PIN ASSIGNMENT



TO-220FB-3L

Absolute Maximum Ratings(T_A = 25^oC unless otherwise noted)

Symbol	Parameter			Ratings	Units
V_{DSS}	Drain to Source Voltage	Drain to Source Voltage			V
V_{GSS}	Gate to Source Voltage			±20	V
I _D	Drain Current	-Continuous (T _C = 25°C)	(Note 1)	140	А
I _{DM}	Drain Current	- Pulsed		470	Α
E _{AS}	Single Pulsed Avalanche E	nergy	(Note 2)	700	mJ
D	Power Dissipation	(T _C = 25°C)		250	W
P_{D}	Power Dissipation	- Derate above 25°C		1.0	W/°C
T_J , T_{STG}	Operating and Storage Temperature Range			-55 to +175	°C

Thermal Characteristics

Symbol	Parameter	Ratings	Units
$R_{\theta JC}$	Thermal Resistance, Junction to Case	0.65	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	35	-0/00

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Package Marking and Ordering Information $T_C = 25^{\circ}C$ unless otherwise noted

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
MT3205A	MT3205A	TO-220	-	-	50units

Electrical Characteristics

Symbol	Parameter	Parameter Test Conditions				Units
Off Chara	cteristics					
BV _{DSS}	Drain to Source Breakdown Voltage	$I_D = 250 \mu A$, $V_{GS} = 0 V$, $T_J = 25$	60	-	-	V
i	Zero Gate Voltage Drain Current	V _{DS} = 44V, V _{GS} = 0V	-	-	25	μА
DSS	Zero Gate Voltage Drain Guirent	$V_{DS} = 44V, T_{C} = 150^{\circ}C$	-	-	250	μΑ
I_{GSS}	Gate to Body Leakage Current	$V_{GS} = \pm 20V, V_{DS} = 0V$	-	-	±100	nA

On Characteristics

V _{GS(th)}	Gate Threshold Voltage	VGS = VDS, ID = 250μA	2		4	V
		$V_{GS} = 10V, I_D = 100A$	-	3.6	4. 5	
R _{DS(on)}	Static Drain to Source On Resistance	$V_{GS} = 10V, I_D = 56A$ $T_J = 175^{\circ}C$	-	10	-	mΩ

Dynamic Characteristics

C _{iss}	Input Capacitance), OF, (), ()		-	3520	4360	pF
C _{oss}	Output Capacitance	V _{DS} = 25V, V _{GS} = 0V	•	-	550	760	pF
C _{rss}	Reverse Transfer Capacitance	1 - 11/11/12		-	340	470	pF
R _G	Gate Resistance	$V_{GS} = 0V, f = 1MHz$		3	4	5	Ω
Q _{g(tot)}	Total Gate Charge at 10V	V _{GS} = 0V to 10V		-	121	145	nC
Q _{g(th)}	Threshold Gate Charge	V _{GS} = 0V to 2V	V _{DS} = 44V	-	35	46	nC
Q_{gs}	Gate to Source Gate Charge		I _D = 59A	-	45	-	nC
Q _{gs2}	Gate Charge Threshold to Plateau		$I_g = 1mA$		18	-	nC
Q_{gd}	Gate to Drain "Miller" Charge			-	39	-	nC

Switching Characteristics

t _{ON}	Turn-On Time		-	99	137	ns
t _{d(on)}	Turn-On Delay Time]	-	19	38	ns
t _r	Turn-On Rise Time	$V_{DD} = 28V, I_{D} = 59A$ $V_{GS} = 10V, R_{GEN} = 2.5\Omega$	-	127	251	ns
t _{d(off)}	Turn-Off Delay Time	V _{GS} - 10V, K _{GEN} - 2.312	-	47	73	ns
t _f	Turn-Off Fall Time		-	19	49	ns
t _{OFF}	Turn-Off Time		-	67	89	ns

Drain-Source Diode Characteristics

V_{SD}	Drain to Source Diode Forward Voltage	$V_{GS} = 0V, I_{SD} = 59A$	-	-	1.2	V
t _{rr}	Reverse Recovery Time	V _{GS} = 0V, I _{SD} = 59A	-	49	-	ns
Q _{rr}	Reverse Recovery Charge	$dI_F/dt = 100A/\mu s$	-	78	-	nC

Notes:
 1: Calculated continuous current based on maximum allowable junction temperature. Package limited to 75A continuous, see Figure 9.
 2: L = 0.21mH, I_{AS} = 59A, V_{DD} = 50V, V_{GS} = 10V, R_G = 25Ω, Starting T_J = 25°C

Typical Performance Characteristics

Figure 1. On-Region Characteristics

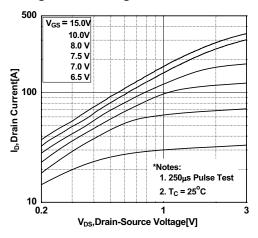


Figure 3. On-Resistance Variation vs.

Drain Current and Gate Voltage

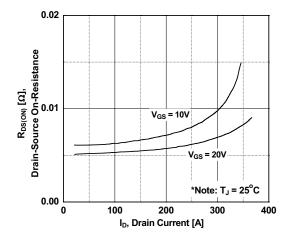


Figure 5. Capacitance Characteristics

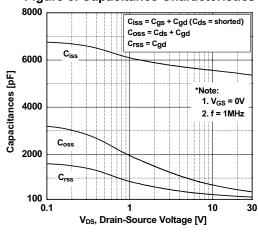


Figure 2. Transfer Characteristics

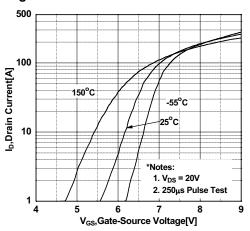


Figure 4. Body Diode Forward Voltage Variation vs. Source Current and Temperature

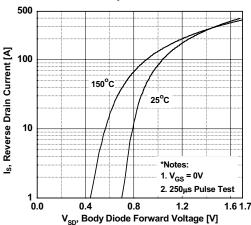
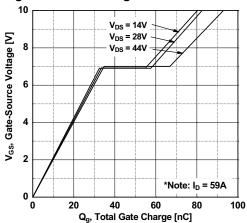


Figure 6. Gate Charge Characteristics



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Typical Performance Characteristics (Continued)

Figure 7. Breakdown Voltage Variation vs. Temperature

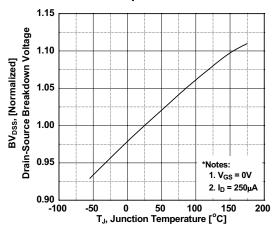


Figure 9. Maximum Safe Operating Area

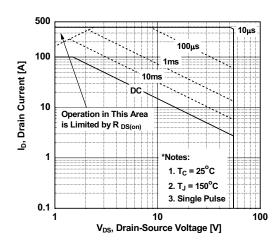


Figure 8. On-Resistance Variation vs. Temperature

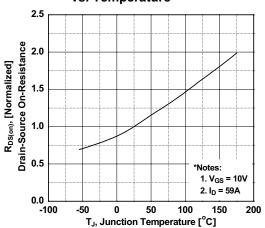


Figure 10. Maximum Drain Current vs. Case Temperature

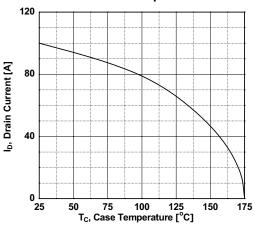
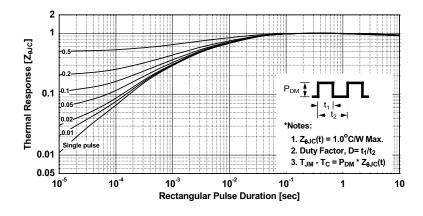
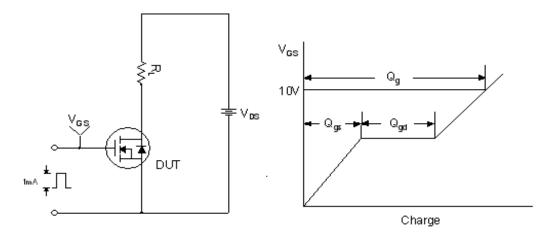


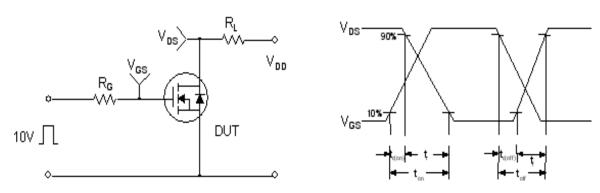
Figure 11. Transient Thermal Response Curve



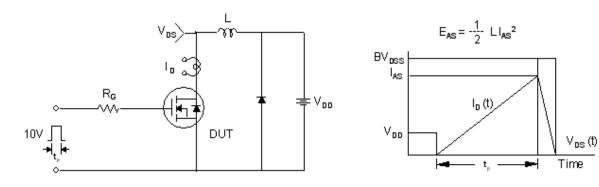
Gate Charge Test Circuit & Waveform



Resistive Switching Test Circuit & Waveforms



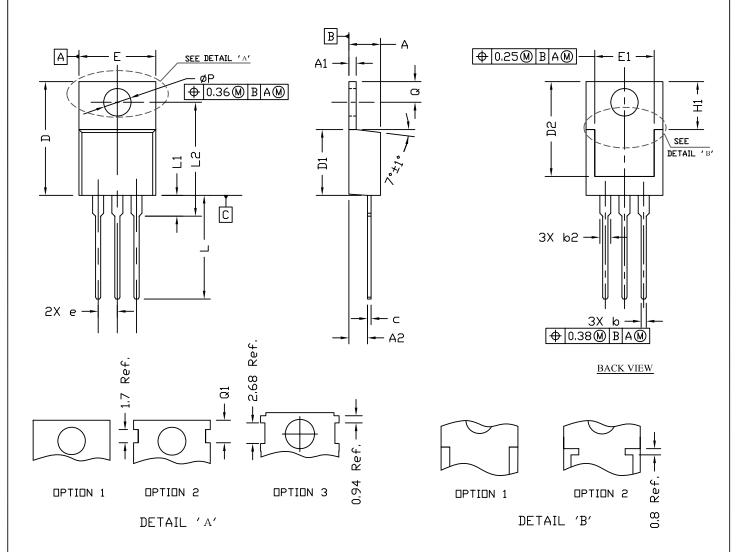
Unclamped Inductive Switching Test Circuit & Waveforms



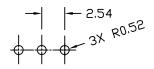
Peak Diode Recovery dv/dt Test Circuit & Waveforms DUT **╞** V ₀ ₀ ∏∏ V G S \bullet dv/dt controlled by R $_{\text{G}}$ \bullet I_{SD} controlled by pulse period Gate Pulse Width Gate Pulse Period V _{G S} 1 0 V (Driver) I_{FM} , Body Diode Forward Current Isp d i/d t (DUT) Body Diode Reverse Current V_{DS} (DUT) Body Diode Recovery dv/dt Body Diode Forward Voltage Drop

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TO220 PACKAGE OUTLINE



RECOMMENDATION OF HOLE PATTERN



UNIT: mm

NOTE

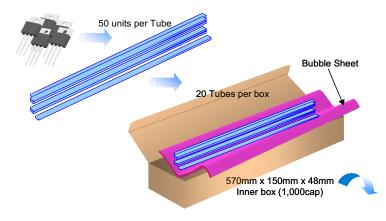
- PACKAGE BODY SIZES EXCLUDE MOLD FLASH AND GATE BURRS. MOLD FLASH SHOULD BE LESS THAN 6 MIL.
- 2. TOLERANCE 0.100 MILLIMETERS UNLESS OTHERWISE SPECIFIED.
- 3. CONTROLLING DIMENSION IS MILLIMETER.
- CONVERTED INCH DIMENSIONS ARE NOT NECESSARILY EXACT.

SUBBULS	DIMENSIONS IN MILLIMETERS			DIME	II NI ZNOIZN	NCHES		
21MBUL2	MIN	NDM	MAX	MIN	NDM	MAX		
Α	4.30	4.45	4.72	0.169	0.175	0.186		
A1	1.15	1.27	1.40	0.045	0.050	0.055		
A2	2.20	2.67	2.90	0.087	0.105	0.114		
b	0.69	0.81	0.95	0.027	0.032	0.037		
b2	1.17	1.37	1.45	0.046	0.050	0.068		
_	0.36	0.38	0.60	0.014	0.015	0.024		
D	14.50	15.44	15.80	0.571	0.608	0.622		
D1	8.59	9.14	9.65	0.338	0.360	0.380		
D2	11.43	11.73	12.48	0.450	0.462	0,491		
е		2.54 BS0	,		0.100 BSC	100 BSC.		
Ε	9.66	10.03	10.54	0.380	0.395	0.415		
E1	6.22			0.245				
H1	6.10	6.30	6.50	0.240	0.248	0.256		
L	12.27	12.82	14.27	0.483	0.505	0.562		
L1	2.47		3.90	0.097		0.154		
L2			16.70			0.657		
Q	2.59	2.74	2.89	0.102	0.108	0.114		
ØΡ	3.50	3.84	3.89	0.138	0.151	0.153		
Q1	2.70		2.90	0.106		0.114		

TO-220 Short Lead Tube Packing Data

TO-220 Short Lead Tube Packing

Configuration: Figure 1.0



Packaging Description:

Packaging Description:

To-220 parts are shipped normally in tube. The tube is made of PVC plastic treated with a nt-static agent. These tubes in s tandard option are placed inside a dissipative plastic bubble sheet, barcode labeled, and placed inside a boxm ade of r ecyclable co rrugated pa per. One b ox contains twenty tubes maximum (see fig. 1.0). And one or several of t hase boxes a re p laced inside a labeled shipping box which comes in different sizes depending on the number of parts shipped. The units in this option are placed inside a small box laid with anti-static bubble sheet. These larger boxes then will be p laced finally inside a labeled shipping box which still comes in different sizes depending on the number of units shipped.



TO-220 Short Lead Packaging Information: Figure 2.0

TO-220 Packaging Information				
Packaging Option	Standard (no flow code)			
Packaging type	Rail/Tube			
Qty per Tube/ Inner Box	50			
Inner Box Dimension (mm)	570x150x48			
Max qty per Box	1,000			
Outer Box Dimension (mm)	590x330x245			
Max qty per Box	8,000			
Weight per unit (gm)	1.9588			
Note/Comments				

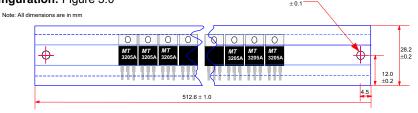
Inner Box Barcode Label Sample

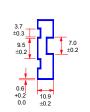


Outer Box Barcode Label Sample



TO-220 Short Lead Tube Configuration: Figure 3.0





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